



SHEET 1 OF 1

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| SUBSTITUTE FORM PTO-1449 U.S. DEPARTMENT OF COMMERCE INFORMATION DISCLOSURE CITATION | | ATTY. DOCKET NO. 00-40387-US | SERIAL NO. 09/749,258 |
| | | APPLICANT: Hennenhoefer et al. | |
| | | FILING DATE December 27, 2000 | GROUP 2611 |
| | | | |

U.S. PATENT DOCUMENTS

| EXAMINER INITIAL | | DOCUMENT NUMBER | DATE | NAME | CLASS | SUBCLASS | FILING DATE (IF APPROPRIATE) |
|---------------------|----|--------------------|----------|---------------|----------|----------|---------------------------------|
| ly | AA | 5,544,161 | 08/06/96 | Bigham et al. | 370/58.1 | 370/60 | |
| ly | AB | 6,021,158 | 02/01/00 | Schurr et al. | 375/211 | 375/220 | |
| ab | AC | 6,041,056 | 03/21/00 | Bigham et al. | 370/395 | 370/461 | |
| | AD | | | | | | |
| | AE | | | | | | |

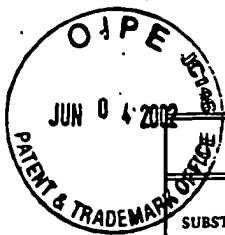
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FOREIGN PATENT DOCUMENTS

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| | AF | | | | | | | |

OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)

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| AG | |
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| EXAMINER Kuhner Rm | DATE CONSIDERED 12/18/01 |
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| SUBSTITUTE FORM PTO-1449 | | U.S. DEPARTMENT OF COMMERCE | |
| INFORMATION DISCLOSURE CITATION | | ATTY. DOCKET NO. 00-403287 (242239.20001) | SERIAL NO. |
| | | | 09/749,258 |
| | | APPLICANT: Hennenhoefer, et al. | |
| | | FILING DATE 12/27/00 | GROUP 2611 |

U.S. PATENT DOCUMENTS

| EXAMINER INITIAL | | DOCUMENT NUMBER | DATE | NAME | CLASS | SUBCLASS | FILING DATE (IF APPROPRIATE) |
|---------------------|----|--------------------|----------------|--------------------|-------|----------|---------------------------------|
| NY | AA | 5,485,630 | Jan. 16, 1996 | Lee, et al. | | | |
| NY | AB | 5,828,403 | Oct. 27, 1998 | DeRodeff, et al. | | | |
| NY | AC | 5,946,301 | Aug. 31, 1999 | Swanson, et al. | | | |
| NY | AD | 5,982,741 | Nov. 9, 1999 | Ethier | | | |
| NY | AE | 6,208,833 | March 27, 2001 | Preschutti, et al. | | | |

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